Low Power GaAs MMIC Double Balanced Mixer

1. Device Overview

1.1 General Description
The MM1-1044L is a low power GaAs MMIC double balanced mixer that is designed for and operates at the K and Ka band 5G frequencies. MM1-1044L is a low power Ka band mixer that works well as both an up and down converter. This mixer offers low conversion loss and high LO to RF isolations over a broadband Ku to Ka band. The sister MM1-1044H is recommended for high linearity applications. The MM1-1044L is available as both wire bondable die and as connectorized modules.

1.2 Features
- Low +7 dBm minimum input drive
- Low cost Ka band mixer
- Small 0.77mm x 1.17mm form factor
- 5G band coverage

1.3 Applications
- Mobile test and measurement equipment
- Power efficient modules
- 5G transceivers

1.4 Functional Block Diagram

1.5 Part Ordering Options

<table>
<thead>
<tr>
<th>Part Number</th>
<th>Description</th>
<th>Package</th>
<th>Green Status</th>
<th>Product Lifecycle</th>
<th>Export Classification</th>
</tr>
</thead>
<tbody>
<tr>
<td>MM1-1044LCH-2</td>
<td>Wire bondable die</td>
<td>CH</td>
<td></td>
<td>Active</td>
<td>EAR99</td>
</tr>
<tr>
<td>MM1-1044LS</td>
<td>Connectorized module; 2.4 mm connectors</td>
<td>S</td>
<td>RoHS</td>
<td>Active</td>
<td>EAR99</td>
</tr>
<tr>
<td>MM1-1044LS-KKS</td>
<td>Connectorized module; 2.92 mm connectors</td>
<td>S</td>
<td></td>
<td>Active</td>
<td>EAR99</td>
</tr>
</tbody>
</table>

1 Refer to our [website](#) for a list of definitions for terminology presented in this table.
Table of Contents

1. Device Overview .................................. 1
   1.1 General Description ....................... 1
   1.2 Features ..................................... 1
   1.3 Applications .................................. 1
   1.4 Functional Block Diagram ............... 1
   1.5 Part Ordering Options .................... 1
2. Port Configurations and Functions ...... 3
   2.1 Port Diagram .................................. 3
   2.2 Port Functions ............................... 3
3. Specifications .................................... 4
   3.1 Absolute Maximum Ratings .............. 4
   3.2 Package Information ....................... 4
   3.3 Recommended Operating Conditions . 4
   3.4 Sequencing Requirements ............... 4
   3.5 Electrical Specifications ............... 5
   3.6 Typical Performance Plots ............. 6
      3.6.1 Typical Performance Plots: IP3 .. 8
      3.6.2 Typical Performance Plots: LO
          Harmonic Isolation ....................... 9
      3.6.3 Typical Spurious Performance:
          Down-Conversion ........................ 10
      3.6.4 Typical Spurious Performance: Up-
          Conversion ............................... 10
4. Die Mounting Recommendations ....... 11
   4.1 Mounting and Bonding
      Recommendations .......................... 11
   4.2 Handling Precautions .................... 11
   4.3 Bonding Diagram ........................... 12
5. Mechanical Data ............................... 13
   5.1 CH Package Outline Drawing .......... 13
   5.2 S Package Outline Drawing .......... 13

Revision History

<table>
<thead>
<tr>
<th>Revision Code</th>
<th>Revision Date</th>
<th>Comment</th>
</tr>
</thead>
<tbody>
<tr>
<td>-</td>
<td>February 2018</td>
<td>Datasheet Initial Release</td>
</tr>
</tbody>
</table>
2. Port Configurations and Functions

2.1 Port Diagram
A top-down view of the MM1-1044L’s CH package outline drawing is shown below. The MM1-1044L has the input and output ports given in Port Functions. The MM1-1044L can be used in either an up or down conversion. For configuration A, input the LO into port 1, use port 3 for the RF, and port 2 for the IF. For configuration B, input the LO into port 3, use port 1 for the RF, and port 2 for the IF.

![Port Diagram](image)

2.2 Port Functions

<table>
<thead>
<tr>
<th>Port</th>
<th>Function</th>
<th>Description</th>
<th>Equivalent Circuit for Package</th>
</tr>
</thead>
<tbody>
<tr>
<td>Port 1</td>
<td>LO (Configuration A) RF (Configuration B)</td>
<td>Port 1 is DC short for the CH and S packages.</td>
<td>P1</td>
</tr>
<tr>
<td>Port 2</td>
<td>IF</td>
<td>Port 2 is diode connected for the CH and S package.</td>
<td>P2</td>
</tr>
<tr>
<td>Port 3</td>
<td>RF (Configuration A) LO (Configuration B)</td>
<td>Port 3 is DC open for the CH and S packages.</td>
<td>P3</td>
</tr>
<tr>
<td>GND</td>
<td>Ground</td>
<td>CH package ground path is provided through the substrate and ground bond pads. S package ground provided through metal housing and outer coax conductor.</td>
<td>GND</td>
</tr>
</tbody>
</table>
3. Specifications

3.1 Absolute Maximum Ratings
The Absolute Maximum Ratings indicate limits beyond which damage may occur to the device. If these limits are exceeded, the device may be inoperable or have a reduced lifetime.

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Maximum Rating</th>
<th>Units</th>
</tr>
</thead>
<tbody>
<tr>
<td>Port 1 DC Current</td>
<td>TBD</td>
<td>mA</td>
</tr>
<tr>
<td>Port 2 DC Current</td>
<td>TBD</td>
<td>mA</td>
</tr>
<tr>
<td>Power Handling, at any Port</td>
<td>+TBD</td>
<td>dBm</td>
</tr>
<tr>
<td>Operating Temperature</td>
<td>-55 to +100</td>
<td>°C</td>
</tr>
<tr>
<td>Storage Temperature</td>
<td>-65 to +125</td>
<td>°C</td>
</tr>
</tbody>
</table>

3.2 Package Information

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Details</th>
<th>Rating</th>
</tr>
</thead>
<tbody>
<tr>
<td>ESD</td>
<td>Human Body Model (HBM), per MIL-STD-750, Method 1020</td>
<td>TBD</td>
</tr>
<tr>
<td>Weight</td>
<td>S Package</td>
<td>12 g</td>
</tr>
</tbody>
</table>

3.3 Recommended Operating Conditions
The Recommended Operating Conditions indicate the limits, inside which the device should be operated, to guarantee the performance given in Electrical Specifications. Operating outside these limits may not necessarily cause damage to the device, but the performance may degrade outside the limits of the electrical specifications. For limits, above which damage may occur, see Absolute Maximum Ratings.

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Min</th>
<th>Nominal</th>
<th>Max</th>
<th>Units</th>
</tr>
</thead>
<tbody>
<tr>
<td>$T_A, \text{ Ambient Temperature}$</td>
<td>-55</td>
<td>+25</td>
<td>+100</td>
<td>°C</td>
</tr>
<tr>
<td>LO Input Power</td>
<td>+7</td>
<td></td>
<td>+15</td>
<td>dBm</td>
</tr>
</tbody>
</table>

3.4 Sequencing Requirements
There is no requirement to apply power to the ports in a specific order. However, it is recommended to provide a 50Ω termination to each port before applying power. This is a passive diode mixer that requires no DC bias.
3.5 Electrical Specifications
The electrical specifications apply at $T_A=+25^\circ\text{C}$ in a 50Ω system. Typical data shown is for the connectorized S package mixer used in the forward direction with a $+9\text{ dBm}$ sine wave input. Specifications shown for configuration A (B).

Min and Max limits apply only to our connectorized units and are guaranteed at $T_A=+25^\circ\text{C}$. All bare die are 100% DC tested and visually inspected. RF testing of our die is performed on a sample basis to verify conformance to datasheet guaranteed specifications.

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Test Conditions</th>
<th>Min</th>
<th>Typical</th>
<th>Max</th>
<th>Units</th>
</tr>
</thead>
<tbody>
<tr>
<td>RF (Port 3) Frequency Range</td>
<td></td>
<td>10</td>
<td></td>
<td>44</td>
<td>GHz</td>
</tr>
<tr>
<td>LO (Port 1) Frequency Range</td>
<td></td>
<td>10</td>
<td></td>
<td>44</td>
<td>GHz</td>
</tr>
<tr>
<td>I (Port 2) Frequency Range</td>
<td></td>
<td>0</td>
<td></td>
<td>14</td>
<td>GHz</td>
</tr>
<tr>
<td>Conversion Loss (CL)²</td>
<td>$RF/LO = 9 - 44\text{ GHz}$</td>
<td></td>
<td>7.6</td>
<td>13.5</td>
<td>dB</td>
</tr>
<tr>
<td></td>
<td>$I = \text{DC - 4 GHz}$</td>
<td></td>
<td>(8.6)</td>
<td>(14.5)</td>
<td></td>
</tr>
<tr>
<td></td>
<td>$RF/LO = 9 - 44\text{ GHz}$</td>
<td></td>
<td>9.5</td>
<td></td>
<td>dB</td>
</tr>
<tr>
<td></td>
<td>$I = \text{4 - 14 GHz}$</td>
<td></td>
<td>(10)</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Noise Figure (NF)³</td>
<td>$RF/LO = 9 - 44\text{ GHz}$</td>
<td></td>
<td>7.6</td>
<td></td>
<td>dB</td>
</tr>
<tr>
<td></td>
<td>$I = \text{DC - 0.2 GHz}$</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Isolation</td>
<td>LO to RF</td>
<td></td>
<td>47</td>
<td></td>
<td>dB</td>
</tr>
<tr>
<td></td>
<td>LO to IF</td>
<td></td>
<td></td>
<td>49</td>
<td>dB</td>
</tr>
<tr>
<td></td>
<td>RF to IF</td>
<td></td>
<td></td>
<td>39</td>
<td>dB</td>
</tr>
<tr>
<td>Input IP3 (IIP3)</td>
<td>$RF/LO = 9 - 44\text{ GHz}$</td>
<td></td>
<td>+12.5</td>
<td></td>
<td>dBm</td>
</tr>
<tr>
<td></td>
<td>$I = \text{DC - 0.2 GHz}$</td>
<td></td>
<td>(+13.7)</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Input 1 dB Gain Compression Point (P1dB)</td>
<td>$RF/IF = 9 - 44\text{ GHz}$</td>
<td></td>
<td>+5</td>
<td></td>
<td>dBm</td>
</tr>
<tr>
<td></td>
<td>$I = \text{DC - 0.2 GHz}$</td>
<td></td>
<td>(+6)</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

² Measured as a down converter to a fixed 91MHz IF.
³ Mixer Noise Figure typically measures within 0.5 dB of conversion loss for IF frequencies greater than 5 MHz.
3.6 Typical Performance Plots

- Conversion Loss: 91 MHz IF, HSLO (dB)
- Configuration A
- Configuration B

- Conversion Loss: 2 GHz IF, HSLO (dB)
- Configuration A
- Configuration B

- Configuration A Conversion Loss vs. LO Power: 91 MHz IF (dB)
- +13 dBm
- +11 dBm
- +9 dBm
- +7 dBm

- Configuration A Conversion Loss vs. LO Power: 2 GHz IF (dB)
- +13 dBm
- +11 dBm
- +9 dBm
- +7 dBm

- Configuration B Conversion Loss vs. LO Power: 91 MHz IF (dB)
- +13 dBm
- +11 dBm
- +9 dBm
- +7 dBm

- Configuration B Conversion Loss vs. LO Power: 2 GHz IF (dB)
- +13 dBm
- +11 dBm
- +9 dBm
- +7 dBm

- Relative IF Response (dB)
- 14 GHz RF - Configuration A
- 14 GHz RF - Configuration B

- Relative IF Response (dB)
- 37 GHz RF - Configuration A
- 37 GHz RF - Configuration B
3.6.1 Typical Performance Plots: IP3

![Typical Performance Plot: Input IP3 vs RF Frequency](image1)

![Typical Performance Plot: Output IP3 vs RF Frequency](image2)

![Typical Performance Plot: Configuration A Input IP3 vs LO Power](image3)

![Typical Performance Plot: Configuration A Output IP3 vs LO Power](image4)

![Typical Performance Plot: Configuration B Input IP3 vs LO Power](image5)

![Typical Performance Plot: Configuration B Output IP3 vs LO Power](image6)
3.6.2 Typical Performance Plots: LO Harmonic Isolation

- **Even LO Harmonic to RF Isolation (dB)**
  - 2xLO Configuration A
  - 2xLO Configuration B
  - 4xLO Configuration A
  - 4xLO Configuration B

- **Even LO Harmonic to IF Isolation (dB)**
  - 2xLO Configuration A
  - 2xLO Configuration B

- **Odd LO Harmonic to RF Isolation (dB)**
  - 3xLO Configuration A
  - 3xLO Configuration B

- **Odd LO Harmonic to IF Isolation (dB)**
  - 3xLO Configuration A
  - 3xLO Configuration B

- **2RF x 2LO Spurious Suppression (dBc) -10 dBm RF Input**
  - Configuration A
  - Configuration B

- **2IF x 1LO Spurious Suppression (dBc) -10 dBm IF Input**
  - Configuration A
  - Configuration B
3.6.3 Typical Spurious Performance: Down-Conversion

Typical spurious data is provided by selecting RF and LO frequencies (± m*LO ± n*RF) within the RF/LO bands, to create a spurious output within the IF band. The mixer is swept across the full spurious band and the mean is calculated. The numbers shown in the table below are for a -10 dBm RF input. Spurious suppression is scaled for different RF power levels by (n-1), where “n” is the RF spur order. For example, the 2RF x 2LO spur is 64 dBc for a -10 dBm input, so a -20 dBm RF input creates a spur that is (2-1) x (-10 dB) lower, or 74 dBc. Data is shown for the frequency plan in 3.6 Typical Performance. mLOxORF plots can be found in section 3.6.2 Typical Performance Plots: LO Harmonic Isolation. mLOx1RF plot is identical to the plot of LO-RF isolation.

Typical Down-conversion spurious suppression (dBc): Config A (B)

<table>
<thead>
<tr>
<th>-10 dBm RF Input</th>
<th>0xLO</th>
<th>1xLO</th>
<th>2xLO</th>
<th>3xLO</th>
<th>4xLO</th>
<th>5xLO</th>
</tr>
</thead>
<tbody>
<tr>
<td>0xRF</td>
<td>-</td>
<td>30 (44)</td>
<td>60 (62)</td>
<td>43 (44)</td>
<td>66 (74)</td>
<td>N/A</td>
</tr>
<tr>
<td>1xRF</td>
<td>24 (21)</td>
<td>Reference</td>
<td>26 (40)</td>
<td>14 (14)</td>
<td>46 (40)</td>
<td>38 (32)</td>
</tr>
<tr>
<td>2xRF</td>
<td>74 (68)</td>
<td>52 (46)</td>
<td>64 (64)</td>
<td>61 (48)</td>
<td>68 (68)</td>
<td>59 (53)</td>
</tr>
<tr>
<td>3xRF</td>
<td>84 (83)</td>
<td>46 (49)</td>
<td>68 (82)</td>
<td>56 (58)</td>
<td>66 (79)</td>
<td>55 (56)</td>
</tr>
<tr>
<td>4xRF</td>
<td>107 (104)</td>
<td>92 (84)</td>
<td>93 (98)</td>
<td>93 (85)</td>
<td>100 (101)</td>
<td>97 (86)</td>
</tr>
<tr>
<td>5xRF</td>
<td>N/A</td>
<td>107 (103)</td>
<td>88 (105)</td>
<td>90 (94)</td>
<td>100 (114)</td>
<td>93 (96)</td>
</tr>
</tbody>
</table>

3.6.4 Typical Spurious Performance: Up-Conversion

Typical spurious data is taken by mixing an input within the IF band, with LO frequencies (± m*LO ± n*IF), to create a spurious output within the RF output band. The mixer is swept across the full spurious output band and the mean is calculated. The numbers shown in the table below are for a -10 dBm IF input. Spurious suppression is scaled for different IF input power levels by (n-1), where “n” is the IF spur order. For example, the 2IFx1LO spur is typically 62 dBc for a -10 dBm input with a sine-wave LO, so a -20 dBm IF input creates a spur that is (2-1) x (-10 dB) lower, or 72 dBc. Data is shown for the frequency plan in 3.6 Typical Performance.

Typical Up-conversion spurious suppression (dBc): Config A (B)

<table>
<thead>
<tr>
<th>-10 dBm RF Input</th>
<th>0xIF</th>
<th>1xIF</th>
<th>2xIF</th>
<th>3xIF</th>
<th>4xIF</th>
<th>5xIF</th>
</tr>
</thead>
<tbody>
<tr>
<td>0xIF</td>
<td>-</td>
<td>30 (30)</td>
<td>50 (37)</td>
<td>59 (58)</td>
<td>59 (57)</td>
<td>N/A</td>
</tr>
<tr>
<td>1xIF</td>
<td>24 (21)</td>
<td>Reference</td>
<td>28 (40)</td>
<td>15 (14)</td>
<td>46 (45)</td>
<td>20 (21)</td>
</tr>
<tr>
<td>2xIF</td>
<td>65 (58)</td>
<td>62 (66)</td>
<td>62 (46)</td>
<td>64 (69)</td>
<td>57 (49)</td>
<td>66 (75)</td>
</tr>
<tr>
<td>3xIF</td>
<td>73 (83)</td>
<td>53 (55)</td>
<td>61 (73)</td>
<td>50 (51)</td>
<td>62 (66)</td>
<td>58 (55)</td>
</tr>
<tr>
<td>4xIF</td>
<td>93 (90)</td>
<td>94 (99)</td>
<td>94 (84)</td>
<td>101 (99)</td>
<td>86 (86)</td>
<td>101 (103)</td>
</tr>
<tr>
<td>5xIF</td>
<td>116 (124)</td>
<td>87 (91)</td>
<td>99 (110)</td>
<td>84 (84)</td>
<td>101 (103)</td>
<td>81 (84)</td>
</tr>
</tbody>
</table>
4. Die Mounting Recommendations

4.1 Mounting and Bonding Recommendations
Marki MMICs should be attached directly to a ground plane with conductive epoxy. The ground plane electrical impedance should be as low as practically possible. This will prevent resonances and permit the best possible electrical performance. Datasheet performance is only guaranteed in an environment with a low electrical impedance ground.

**Mounting** - To epoxy the chip, apply a minimum amount of conductive epoxy to the mounting surface so that a thin epoxy fillet is observed around the perimeter of the chip. Cure epoxy according to manufacturer instructions.

**Wire Bonding** - Ball or wedge bond with 0.025 mm (1 mil) diameter pure gold wire. Thermosonic wirebonding with a nominal stage temperature of 150 °C and a ball bonding force of 40 to 50 grams or wedge bonding force of 18 to 22 grams is recommended. Use the minimum level of ultrasonic energy to achieve reliable wirebonds. Wirebonds should be started on the chip and terminated on the package or substrate. All bonds should be as short as possible <0.31 mm (12 mils).

**Circuit Considerations** – 50 Ω transmission lines should be used for all high frequency connections in and out of the chip. Wirebonds should be kept as short as possible, with multiple wirebonds recommended for higher frequency connections to reduce parasitic inductance. In circumstances where the chip more than .001” thinner than the substrate, a heat spreading spacer tab is optional to further reduce bondwire length and parasitic inductance.

4.2 Handling Precautions

**General Handling**
Chips should be handled with care using tweezers or a vacuum collet. Users should take precautions to protect chips from direct human contact that can deposit contaminants, like perspiration and skin oils on any of the chip’s surfaces.

**Static Sensitivity**
GaAs MMIC devices are sensitive to ESD and should be handled, assembled, tested, and transported only in static protected environments.

**Cleaning and Storage:** Do not attempt to clean the chip with a liquid cleaning system or expose the bare chips to liquid. Once the ESD sensitive bags the chips are stored in are opened, chips should be stored in a dry nitrogen atmosphere.
4.3 Bonding Diagram

- Multiple Wirebonds for Reduced Inductance
- Orientation Marker
- Minimum Space Gap/Wirebond Length
5. Mechanical Data

5.1 CH Package Outline Drawing

1. CH Substrate material is 0.004 in thick GaAs.
2. I/O trace finish is 4.2 microns Au. Ground plane finish is 5 microns Au.

5.2 S Package Outline Drawing
5.3 S-KKS Package Outline Drawing

<table>
<thead>
<tr>
<th>Function</th>
<th>Configuration A</th>
<th>Configuration B</th>
<th>Connector Type</th>
</tr>
</thead>
<tbody>
<tr>
<td>LO</td>
<td>1</td>
<td>3</td>
<td>2.92 mm Female</td>
</tr>
<tr>
<td>IF</td>
<td>2</td>
<td>2</td>
<td>SMA Female</td>
</tr>
<tr>
<td>RF</td>
<td>3</td>
<td>1</td>
<td>2.92 mm Female</td>
</tr>
</tbody>
</table>

Note: S-Package Connectors are not removable.

Marki Microwave reserves the right to make changes to the product(s) or information contained herein without notice.
Marki Microwave makes no warranty, representation, or guarantee regarding the suitability of its products for any particular purpose, nor does Marki Microwave assume any liability whatsoever arising out of the use or application of any product.

© Marki Microwave, Inc.